Search Notes



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10576220

Applicant(s)/Patent Under Reexamination

LEE ET AL.

Examiner

Art Unit

MARCOS BATISTA

2617

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 455 | 466 | 2/14/2008 | mb |
| 455 | 95 | 2/14/2008 | mb |

SEARCH NOTES

| Search Notes | Date | Examiner |
|---------------------------------------|-----------|----------|
| Consulted with Steve D'Agosta | 2/19/2008 | mb |
| Consulted with TA - Yogesh Aggarwal | 2/14/2008 | mb |
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| East Search | 2/14/2008 | mb |
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| East Search | 12/5/2008 | mb |
| Consulted with Rafael Perez Gutierrez | 12/4/2008 | mb |
| East Search | 6/27/2009 | mb |
| Consulted with Rafael Perez Gutierrez | 6/29/2009 | mb |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
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| 455 | all | 6/29/2009 | mb |
| 370 | all | 6/29/2009 | mb |

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